

April 1988 Revised August 1999

74F30 8-Input NAND Gate

General Description

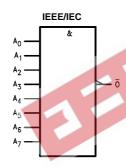
This device contains a single gate, which performs the logic NAND function.

Ordering Code:

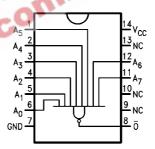
Order Number	Package Number	Package Description
74F30SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74F30SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F30PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the letter "X" to the ordering code

Logic Symbol



Connection Diagram



Unit Loading/Fan Out

Din Names	Description	U.L.	Input I _{IH} /I _{IL}		
Pin Names	Description	HIGH/LOW	Output I _{OH} /I _{OL}		
A ₀ -A ₇	Inputs	1.0/1.0	20 μA/–0.6 mA		
ō	Output	50/33.3	-1 mA/20 mA		

Function Table

Inputs							Output	
A ₀	A ₁	A ₂	A ₃	A ₄	A ₅ A ₆ A ₇		A ₇	0
L	Х	Χ	Х	Χ	Χ	Χ	Χ	Н
Х	L	X	X	Χ	X	Χ	Χ	Н
Χ	Χ	L	Χ	Χ	Χ	Χ	Χ	Н
Χ	Χ	Χ	L	Χ	Χ	Χ	Χ	Н
Χ	Χ	Χ	Χ	L	Χ	Χ	Χ	Н
Х	Χ	Χ	Χ	Χ	L	Χ	Χ	Н
Χ	Χ	Χ	Χ	Χ	Χ	L	Χ	Н
Χ	Χ	Χ	Χ	Χ	Χ	Χ	L	Н
Н	Н	Н	Н	Н	Н	Н	Н	L

H = HIGH Voltage Level L = LOW Voltage Level

X = Immaterial

Absolute Maximum Ratings(Note 1)

−65°C to +150°C

Voltage Applied to Output

Storage Temperature

in HIGH State (with $V_{CC} = 0V$)

Standard Output -0.5V to V_{CC} 3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) $\qquad \qquad \text{twice the rated I}_{\text{OL}} \, (\text{mA})$

Recommended Operating Conditions

Free Air Ambient Temperature 0° C to $+70^{\circ}$ C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

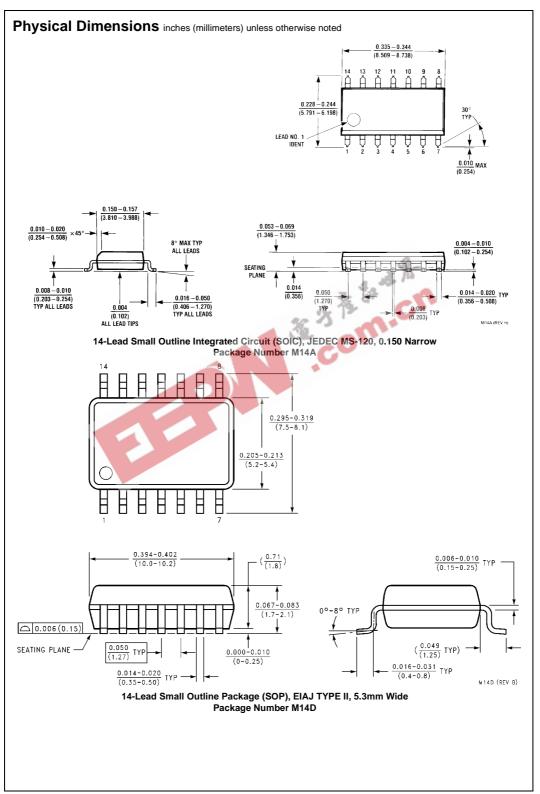
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

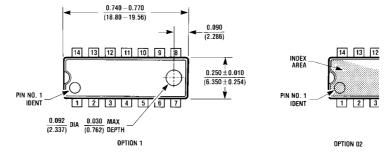
Symbol	Parameter	Min	Тур	Max	Units	V _{CC}	Conditions	
V _{IH}	Input HIGH Voltage	2.0			V	70	Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage			0.8	V	-	Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage			-1.2	V	Min	I _{IN} = −18 mA	
V _{OH}	Output HIGH 10% V _{CC}	2.5	90	22 "	V	Min	I _{OH} = -1 mA	
	Voltage 5% V _{CC}	2.7	1 132		CAN ST.	iviin	$I_{OH} = -1 \text{ mA}$	
V _{OL}	Output LOW 10% V _{CC}			0.5	V	Min	I _{OL} = 20 mA	
	Voltage 10% VCC							
I _{IH}	Input HIGH	11		5.0	μА	Max	V _{IN} = 2.7V	
	Current							
I _{BVI}	Input HIGH Current			7.0		Max	V 7.0V	
	Breakdown Test			7.0	μΑ	IVIAX	$V_{IN} = 7.0V$	
I _{CEX}	Output HIGH			50	μА	Max	V V	
	Leakage Current			50	50 μΑ		$V_{OUT} = V_{CC}$	
V _{ID}	Input Leakage	4.75			V	0.0	$I_{ID} = 1.9 \mu A$	
	Test	4.75					All Other Pins Grounded	
I _{OD}	Output Leakage			3.75	μА	0.0	V _{IOD} = 150 mV	
	Circuit Current						All Other Pins Grounded	
I _{IL}	Input LOW Current			-0.6	mA	Max	V _{IN} = 0.5V	
Ios	Output Short-Circuit Current	-60		-150	mA	Max	V _{OUT} = 0V	
I _{CCH}	Power Supply Current		0.5	1.5	mA	Max	V _O = HIGH	
I _{CCL}	Power Supply Current			4.5	mA	Max	$V_O = LOW$	

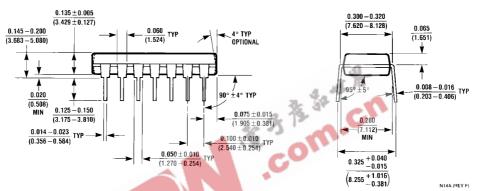
AC Electrical Characteristics

Symbol			T _A = +25°C		T _A = 0°C to +70°C		
	Parameter	$egin{aligned} \mathbf{V_{CC}} = +5.0\mathbf{V} \\ \mathbf{C_L} = 50 \ \mathbf{pF} \end{aligned}$			V _{CC} = +5.0V C _L = 50 pF		Units
		Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	1.0	3.7	5.0	1.0	5.5	
t _{PHL}	A_n to \overline{O}	1.5	2.8	5.0	1.5	5.5	ns



Physical Dimensions inches (millimeters) unless otherwise noted (Continued)





14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N14A

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